

# ZXMN3G32DN8 30V SO8 dual N-channel enhancement mode MOSFET

### **Summary**

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> (Ω)	I <sub>D</sub> (A)
30	0.028 @ V <sub>GS</sub> = 10V	7.1
	0.045 @ V <sub>GS</sub> = 4.5V	5.6



### Description

This new generation Trench MOSFET from Zetex features low on-resistance and fast switching speed.

### Features

- · Low on-resistance
- 4.5V gate drive capability
- Fast switching bullet

### Applications

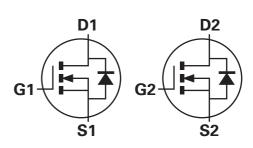
- DC-DC Converters
- Power management functions
- Motor Control
- Backlighting

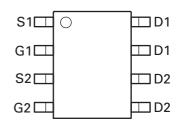
### Ordering information

DEVICE	Reel size	Tape width	Quantity	
	(inches)	(mm)	per reel	
ZXMN3G32DN8TA	7	12	500	

### **Device marking**

ZXMN 3G32D





## Absolute maximum ratings

Parameter	Symbol	Limit	Unit
Drain source voltage	V <sub>DSS</sub>	30	V
Gate source voltage	V <sub>GS</sub>	±20	V
Continous Drain Current @ $V_{GS}=10$ ; $T_A=25^{\circ}C^{(b)}$ @ $V_{GS}=10$ ; $T_A=70^{\circ}C^{(b)}$ @ $V_{GS}=10$ ; $T_A=25^{\circ}C^{(a)}$	ID	7.1 5.7 5.5	A A A
Pulsed drain current <sup>(c)</sup>	I <sub>DM</sub>	33.6	А
Continuous source current (body diode) <sup>(b)</sup>	ا <sub>S</sub>	3.1	А
Pulsed source current (body diode) <sup>(c)</sup>	I <sub>SM</sub>	33.6	А
Power dissipation at $T_A = 25^{\circ}C^{(a)(d)}$	PD	1.25	W
Linear derating factor		10	mW/°C
Power dissipation at $T_A = 25^{\circ}C^{(a)(e)}$	PD	1.8	W
Linear derating factor		14	mW/°C
Power dissipation at $T_A = 25^{\circ}C^{(b)(d)}$	PD	2.1	W
Linear derating factor		17	mW/°C
Operating and storage temperature range	T <sub>j</sub> , T <sub>stg</sub>	-55 to 150	°C

### **Thermal resistance**

Parameter	Symbol	Limit	Unit
Junction to ambient <sup>(a)(d)</sup>	R <sub>OJA</sub>	100	°C/W
Junction to ambient <sup>(a)(e)</sup>	R <sub>OJA</sub>	70	°C/W
Junction to ambient <sup>(b)(d)</sup>	R <sub>OJA</sub>	60	°C/W
Junction to lead <sup>(f)</sup>	R <sub>OJL</sub>	51	°C/W

### NOTES:

(a) For a device surface mounted on 25mm x 25mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions.

(b) For a device surface mounted on FR4 PCB measured at t  $\leq$  10 sec.

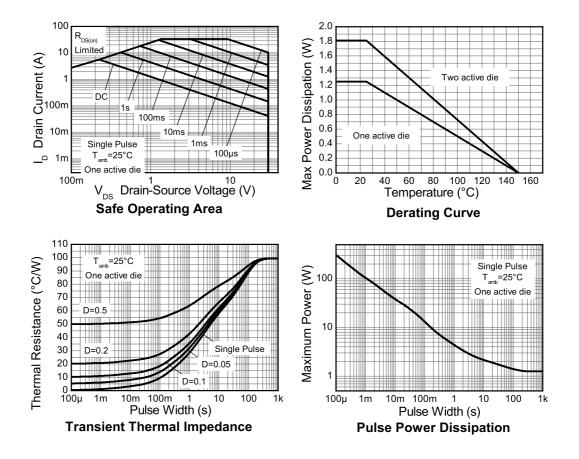
(c) Repetitive rating - 25mm x 25mm FR4 PCB, D=0.02, pulse width 300μs - pulse width limited by maximum junction temperature.

(d) For a dual device with one active die.

(e) For a device with two active die running at equal power.

(f) Thermal resistance from junction to solder-point (at end of drain lead).

## **Thermal characteristics**



Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions
Static	1		I	•		
Drain-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	30			V	I <sub>D</sub> = 250μA, V <sub>GS</sub> =0V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>			0.5	μA	V <sub>DS</sub> = 30V, V <sub>GS</sub> =0V
Gate-Body Leakage	I <sub>GSS</sub>			100	nA	$V_{GS}=\pm 20V, V_{DS}=0V$
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	1.0		3.0	V	$I_D=250\mu A, V_{DS}=V_{GS}$
Static Drain-Source On-State Resistance <sup>(*)</sup>	R <sub>DS(on)</sub>			0.028 0.045	Ω Ω	V <sub>GS</sub> = 10V, I <sub>D</sub> = 6.0A V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 4.9A
Forward Transconductance <sup>(*)(†)</sup>	9 <sub>fs</sub>		12		S	V <sub>DS</sub> = 15V, I <sub>D</sub> = 6.0A
Dynamic <sup>(†)</sup>	· · · · ·		1	•	1	
Input Capacitance	C <sub>iss</sub>		472		pF	
Output Capacitance	C <sub>oss</sub>		178		pF	V <sub>DS</sub> = 15V, V <sub>GS</sub> =0V f=1MHz
Reverse Transfer Capacitance	C <sub>rss</sub>		65		pF	- 1 - 1101112
Switching <sup>(‡)(†)</sup>						
Turn-On-Delay Time	t <sub>d(on)</sub>		2.5		ns	
Rise Time	t <sub>r</sub>		3.1		ns	V <sub>DD</sub> = 15V, I <sub>D</sub> = 1A R <sub>G</sub> ≅ 6.0Ω, V <sub>GS</sub> =10V
Turn-Off Delay Time	t <sub>d(off)</sub>		14		ns	$M_{\rm G} = 0.052, V_{\rm GS} = 10V$
Fall Time	t <sub>f</sub>		9.7		ns	
Total Gate Charge	Qg		10.5		nC	V <sub>DS</sub> = 15V, V <sub>GS</sub> = 10V
Gate-Source Charge	Q <sub>gs</sub>		1.86		nC	I <sub>D</sub> = 6A
Gate Drain Charge	Q <sub>gd</sub>		2.3		nC	1
Source-drain diode	1		1	1		
Diode Forward Voltage <sup>(*)</sup>	V <sub>SD</sub>		0.68	1.2	V	T <sub>j</sub> =25°C, I <sub>S</sub> = 1.7A, V <sub>GS</sub> =0V

## Electrical characteristics (at $T_{amb} = 25^{\circ}C$ unless otherwise stated)

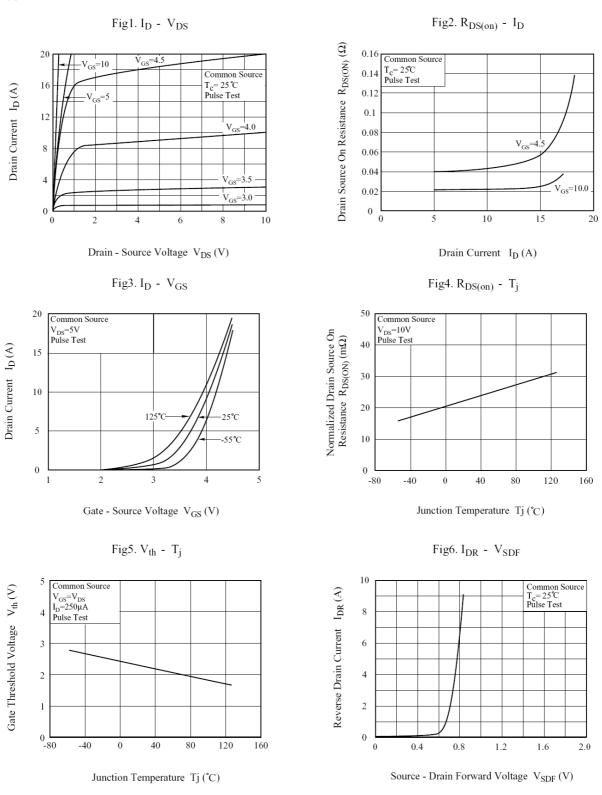
NOTES:

(\*) Measured under pulsed conditions. Pulse width  $\leq$  300  $\mu s;$  duty cycle  $\leq\!\!2\%.$ 

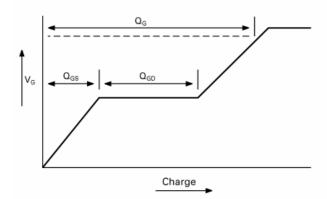
(†) For design aid only, not subject to production testing

(‡) Switching characteristics are independent of operating junction temperature.

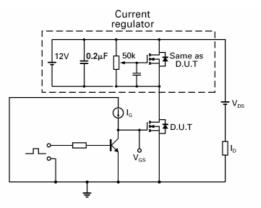
## **Typical characteristics**



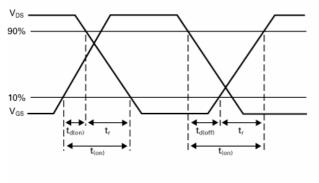
## **Test circuits**



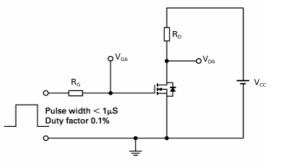
Basic gate charge waveform



Gate charge test circuit

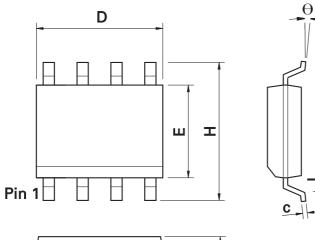


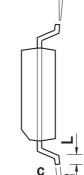
Switching time waveforms

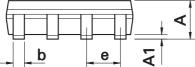


Switching time test circuit

## Package outline - SO8







Seating Plane

DIM	Inc	hes	Millin	neters	DIM	Inches		Millimeters	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
Α	0.053	0.069	1.35	1.75	е	0.050 BSC		1.27 BSC	
A1	0.004	0.010	0.10	0.25	b	0.013	0.020	0.33	0.51
D	0.189	0.197	4.80	5.00	С	0.008	0.010	0.19	0.25
Н	0.228	0.244	5.80	6.20	θ	0°	8°	0°	8°
E	0.150	0.157	3.80	4.00	h	0.010	0.020	0.25	0.50
L	0.016	0.050	0.40	1.27	-	-	-	-	-

Note: Controlling dimensions are in inches. Approximate dimensions are provided in millimeters

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